

Notice of References Cited	Application/Control No. 09/738,268	Applicant(s)/Patent Under Reexamination LIEU ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,774,974	07-1998	Dunfield et al.	29/596
	B	US-5,459,190	10-1995	Nakamura et al.	264/328.1
	C	US-4,390,649	06-1983	Aharoni, Shaul M.	524/167
	D	US-5,490,319	02-1996	Nakamura et al.	264/272.11
	E	US-5,325,004	06-1994	Mori et al.	310/67R
	F	US-6,043,315	03-2000	Gottschalk et al.	524/505
	G	US-5,856,718	01-1999	Matsushita et al.	310/49R
	H	US-6,195,226	02-2001	Papst, Hans Dieter	360/99.08
	I	US-5,850,318	12-1998	Dunfield et al.	360/98.07
	J	US-5,955,813	09-1999	Bolte et al.	310/254
	K	US-5,958,283	09-1999	Schmid et al.	252/62.54
	L	US-6,291,633	09-2001	Nakamura, Ken	524/397
	M	US-5,659,217	08-1997	Petersen, Christian C.	310/156.26

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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